

Notice of References Cited	Application/Control No. 09/890,490	Applicant(s)/Patent Under Reexamination YEO ET AL.	
	Examiner Duc M. Nguyen	Art Unit 2618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,721,756	02-1998	Liebetreu et al.	375/344
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N	JP 07-297779	11-1995	JP	Enoki	H04B 007/26
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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